

Hisense Electric Co., Ltd.

Application
For
Certification
(FCC ID: W9HLCDC0016)

Computer Peripheral

Prepared and Checked by:	Approved by:
Sign on file	
Robert Li Project Engineer	Alex Li Supervisor Date: 05 November, 2012

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MEASUREMENT / TECHNICAL REPORT

Hisense Electric Co., Ltd.
MODEL: 32W22, LHD32W22US
FCC ID: W9HLCDC0016

05 November, 2012

This report concerns (check one:)	Original Grant X Class II Change
Equipment Type: JBP-Class B Computin	g Device Peripheral
Deferred grant requested per 47 CFR 0.4	457(d)(1)(ii)? Yes NoX
	If yes, defer until:date
Company Name agrees to notify the Con	nmission by:
	date
of the intended date of announcement of that date.	of the product so that the grant can be issued on
Transition Rules Request per 15.37?	Yes NoX
If no, assumed Part 15, Subpart B for un Edition] provision.	nintentional radiator – the new 47 CFR [10-01-11
Report prepared by:	
	Alex Li Intertek Testing Services Shenzhen Ltd. Kejiyuan Branch 6F, D Block, Huahan Building, Langshan Road

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List of attached file

Exhibit Type	File Description	Filename
Test Report	Test Report	report.pdf
Test Setup Photo	Radiated photos	radiated photos.pdf
Test Setup Photo	Conducted photos	conducted photos.pdf
External Photo	External Photos	external photos.pdf
Internal Photo	Internal Photos	internal photos.pdf
Block Diagram	Block Diagram	block.pdf
ID Label / Location	Label Artwork and Location	label.pdf
User Manual	User Manual	manual.pdf
Cover Letter	Letter of Agency	agency.pdf
Cover Letter	Certification Agreement	agreement.pdf

EXHIBIT 1 GENERAL DESCRIPTION

1.0 **General Description**

1.1 Product Description

The Equipment Under Test (EUT) is a LED TV. The device can be used to connecting PC by VGA port. The EUT is powered by 120V/60Hz.

1.2 Related Submittal(s) Grants

This is an application for certification of a computer peripheral.

Other digital functions were reported in the verification report SZ12090412-1.

1.3 Test Methodology

Both AC mains line-conducted and radiated emission measurements were performed according to the procedures in ANSI C63.4 (2009). Radiated emission measurement was performed in Semi-anechoic chamber and conducted emission measurement was performed in shield room. For radiated emission measurement, preliminary scans were performed in the semi-anechoic chamber only to determine the worst case modes. All radiated tests were performed at an antenna to EUT distance of 3 meters, unless stated otherwise in the "Justification Section" of this Application.

1.4 Test Facility

The Semi-anechoic chamber and shielding room used to collect the radiated data and conducted data are **Intertek Testing Services Shenzhen Ltd. Kejiyuan Branch** and located at 6F, D Block, Huahan Building, Langshan Road, Nanshan District, Shenzhen, P. R. China. This test facility and site measurement data have been fully placed on file with the FCC (Registration Number: 242492).

EXHIBIT 2 SYSTEM TEST CONFIGURATION

2.0 **System Test Configuration**

2.1 Justification

The system was configured for testing in a typical fashion (as a customer would normally use it), and in the confines as outlined in ANSI C63.4 (2009).

The device is powered by AC 120V/60Hz during the test. The worst case data was reported in this report.

For maximizing emissions, the EUT was rotated through 360°, the antenna height was varied from 1 meter to 4 meters above the ground plane, and the antenna polarization was changed. The step by step procedure for maximizing emissions led to the data reported in Exhibit 3.0.

The rear of unit shall be flushed with the rear of the table.

The equipment under test (EUT) was configured for testing in a typical fashion (as a customer would normally use it). The EUT was placed on turntable, which enabled the engineer to maximize emissions through its placement in the three orthogonal axes.

The frequency range from 30MHz to 2GHz was searched for spurious emissions from the device. Only those emissions reported were detected. All other emissions were at least 20 dB below the applicable limits.

2.3 2.2 EUT Exercising Software

N/A

2.4 Special Accessories

N/A

2.4 Equipment Modification

Any modifications installed previous to testing by Hisense Electric Co., Ltd. will be incorporated in each production model sold / leased in the United States.

No modifications were installed by Intertek Testing Services Shenzhen Ltd. Kejiyuan Branch.

2.5 Measurement Uncertainty

When determining the test conclusion, the Measurement Uncertainty of test has been considered.

2.6 Support Equipment List and Description

This product was tested in the following configuration:

Refer List:

Description	Manufacturer	Model No.		
Laptop	Lenovo	T420		
Hard Disk	Smart.drive	HD-003		
USB Memory	SanDisk	SDCZ36-002G-P36		
1394 Cable	Smart.drive	Unshielded, Length 180cm		
USB Cable	Smart.drive	Unshielded, Length 155cm		
Dummy Load	N/A	N/A		
VGA Cable	HP	Unshielded, Length 180cm		
HDMI In Cable*3	N/A	Unshielded, Length 110cm		
Component In Cable	N/A	Unshielded, Length 120cm		
PC Audio Cable	N/A	Unshielded, Length 150cm		
Digital Audio Cable	N/A	Unshielded, Length 120cm		
AV In Cable	N/A	Unshielded, Length 120cm		

EXHIBIT 3

EMISSION RESULTS

3.0 **Emission Results**

Data is included worst case configuration (the configuration which resulted in the highest emission levels). A sample calculation, configuration photographs and data tables of the emissions are included.

3.1 Field Strength Calculation

The field strength is calculated by adding the reading on the Spectrum Analyzer to the factors associated with preamplifiers (if any), antennas, cables, pulse desensitization and average factors (when specified limit is in average and measurements are made with peak detectors). A sample calculation is included below.

$$FS = RA + AF + CF - AG + PD + AV$$

where FS = Field Strength in $dB\mu V/m$

RA = Receiver Amplitude (including preamplifier) in $dB\mu V$

CF = Cable Attenuation Factor in dB

AF = Antenna Factor in dB/m AG = Amplifier Gain in dB

PD = Pulse Desensitization in dB

AV = Average Factor in -dB

In the radiated emission table which follows, the reading shown on the data table may reflect the preamplifier gain. An example of the calculations, where the reading does not reflect the preamplifier gain, follows:

$$FS = RA + AF + CF - AG + PD + AV$$

3.1 Field Strength Calculation (cont'd)

Example

Assume a receiver reading of $62.0dB_{\mu}V$ is obtained. The antenna factor of 7.4dB/m and cable factor of 1.6dB is added. The amplifier gain of 29dB is subtracted. The pulse desensitization factor of the spectrum analyzer was 0dB, and the resultant average factor was -10dB. The net field strength for comparison to the appropriate emission limit is $32dB_{\mu}V/m$. This value in $dB_{\mu}V/m$ was converted to its corresponding level in $\mu V/m$.

 $RA = 62.0dB\mu V$ AF = 7.4dB/mCF = 1.6dB

AG = 29.0dBPD = 0dB

AV = -10dB

FS = $62 + 7.4 + 1.6 - 29 + 0 + (-10) = 32dB\mu V/m$

Level in μ V/m = Common Antilogarithm [(32dB μ V/m)/20] = 39.8 μ V/m

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3.2 Radiated Emission Configuration Photograph

Worst Case Radiated Emission At 31.646MHz (VGA Mode)

For electronic filing, the worst case radiated emission configuration photograph is saved with filename: radiated photos.pdf.

3.3 Radiated Emission Data

The data on the following page lists the significant emission frequencies, the limit and the margin of compliance. Numbers with a minus sign are below the limit.

Judgement: Passed by 3.8dB margin (VGA Mode)

TEST PERSONNEL:
Sign on file
Robert Li Project Engineer Typed/Printed Name
04 November, 2012
Date

Company: Hisense Electric Co., Ltd. Date of Test: 04 November, 2012

Model: 32W22

Operating Mode: VGA

Table 1

Radiated Emissions

Polarization	Frequency	Reading	Pre-	Antenna	Net	Limit	Margin
	(MHz)	(dBµV)	Amp	Factor	at 3m	at 3m	(dB)
			Gain	(dB)	(dBµV/m)	(dBµV/m)	
			(dB)				
Horizontal	68.315	46.7	20.0	4.8	31.5	40.0	-8.5
Horizontal	91.131	45.1	20.0	7.2	32.3	43.5	-11.2
Horizontal	171.001	49.4	20.0	9.1	38.5	43.5	-5.0
Horizontal	297.235	42.1	20.0	13.4	35.5	46.0	-10.5
Horizontal	324.880	44.9	20.0	14.2	39.1	46.0	-6.9
Horizontal	496.085	40.9	20.0	17.0	37.9	46.0	-8.1
Horizontal	1550.385	38.0	20.0	27.0	45.0	54.0	-9.0
Vertical	31.646	39.1	20.0	17.1	36.2	40.0	-3.8
Vertical	41.975	40.1	20.0	11.3	31.4	40.0	-8.6
Vertical	90.140	44.6	20.0	7.2	31.8	43.5	-11.7
Vertical	170.997	48.7	20.0	9.1	37.8	43.5	-5.7
Vertical	304.025	40.9	20.0	13.8	34.7	46.0	-11.3
Vertical	815.700	36.4	20.0	22.5	38.9	46.0	-7.1
Vertical	2000.000	38.5	20.0	30.1	48.6	54.0	-5.4

NOTES:

- 1. Quasi-Peak detector is used for frequency up to 1GHz and PEAK detector is used for frequency from 1-2GHz.
- 2. All measurements were made at 3 meters. Harmonic emissions not detected at the 3 meter distances were measured at 0.3- meter and an inverse proportional extrapolation was performed to compare the signal level to the 3 meter limit. No other harmonic emissions than those reported were detected at a test distance of 0.3-meter.
- 3. Negative value in the margin column shows emission below limit.
- 4. All emissions up to 1GHz are below the QP limit and all emissions between 1-2GHz are below the AV limit.

Test Engineer: Robert Li

3.4 Conducted Emission Configuration Photograph

Worst Case Live-Conducted Configuration at 0.190 MHz

For electronic filing, the worst case conducted emission configuration photograph is saved with filename: conducted photos.pdf.

3.5 Conducted Emission Data

Judgement: Passed by 4.1 dB margin

TEST PERSONNEL: Sign on file Robert Li Project Engineer Typed/Printed Name 04 November, 2012

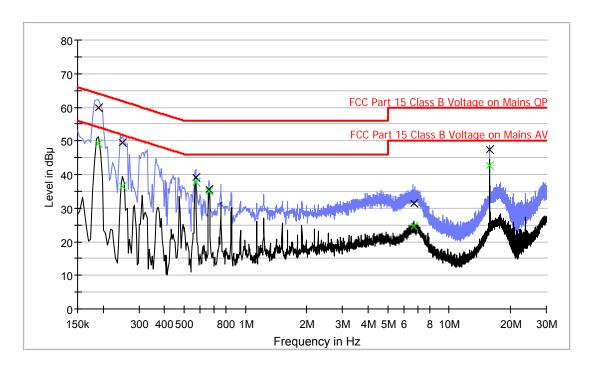
Date

Company: Hisense Electric Co., Ltd. Date of Test: 04 November, 2012

Model: 32W22

Worst Case Operating Mode: VGA

Conducted Emission Test - FCC



Result Table QP

Frequency (MHz)	QuasiPeak (dB µ V)	Line	Corr. (dB)	Margin (dB)	Limit (dB µ V)
0.190000	59.9	L1	9.6	4.1	64.0
0.250000	49.6	L1	9.6	12.2	61.8
0.570000	39.3	L1	9.6	16.7	56.0
0.662000	35.4	L1	9.7	20.6	56.0
6.722000	31.4	L1	9.9	28.6	60.0
15.850000	47.3	L1	10.0	12.7	60.0

Result Table AV

Frequency (MHz)	Average (dB µ V)	Line	Corr. (dB)	Margin (dB)	Limit (dB µ V)
0.190000	49.3	L1	9.6	4.7	54.0
0.250000	36.3	L1	9.6	15.5	51.8
0.570000	37.7	L1	9.6	8.3	46.0
0.662000	35.1	L1	9.7	10.9	46.0
6.722000	24.7	L1	9.9	25.3	50.0
15.850000	42.8	L1	10.0	7.2	50.0

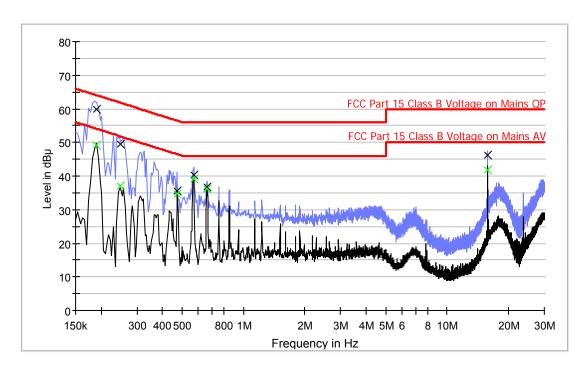
Test Engineer: Robert Li

Company: Hisense Electric Co., Ltd. Date of Test: 04 November, 2012

Model: 32W22

Worst Case Operating Mode: VGA

Conducted Emission Test - FCC



Result Table QP

Frequency (MHz)	QuasiPeak (dB µ V)	Line	Corr. (dB)	Margin (dB)	Limit (dB µ V)
0.190000	59.8	N	9.6	4.2	64.0
0.250000	49.4	N	9.6	12.4	61.8
0.570000	35.4	N	9.6	20.6	56.0
0.662000	40.4	N	9.7	15.6	56.0
6.722000	36.7	N	9.9	23.3	60.0
15.850000	46.3	N	10.0	13.7	60.0

Result Table AV

Frequency	Average	Line	Corr.	Margin	Limit
(MHz)	(dB μ V)		(dB)	(dB)	(dB μ V)
0.190000	49.1	N	9.6	4.9	54.0
0.250000	36.9	N	9.6	14.9	51.8
0.474000	34.6	N	9.6	11.8	46.4
0.570000	39.0	N	9.6	7.0	46.0
0.662000	36.2	N	9.6	9.8	46.0
15.850000	41.9	N	10.1	8.1	50.0

Test Engineer: Robert Li

EXHIBIT 4

EQUIPMENT PHOTOGRAPHS

4.0 **Equipment Photographs**

For electronic filing, photographs of the tested EUT are saved with filename: external photos.pdf and internal photos.pdf.

EXHIBIT 5 PRODUCT LABELLING

5.0 **Product Labelling**

For electronics filing, the FCC ID label artwork and the label location are saved with filename: label.pdf.

EXHIBIT 6 TECHNICAL SPECIFICATIONS

6.0 <u>Technical Specifications</u>

For electronic filing, the block diagram of the tested EUT is saved with filename: block.pdf.

EXHIBIT 7 INSTRUCTION MANUAL

7.0 <u>Instruction Manual</u>

For electronic filing, a preliminary copy of the Instruction Manual is saved with filename: manual.pdf.

This manual will be provided to the end-user with each unit sold / leased in the United States.

EXHIBIT 8 MISCELLANEOUS INFORMATION

8.0 <u>Miscellaneous Information</u>

This miscellaneous information includes emission measuring procedure.

8.1 Emissions Test Procedures

The following is a description of the test procedure used by Intertek Testing Services in the measurements of computer peripheral operating under Part 15, Subpart B rules.

The test set-up and procedures described below are designed to meet the requirements of ANSI C63.4 – 2009.

The computer peripheral equipment under test (EUT) is placed on a wooden turntable which is four feet in diameter and approximately one meter in height above the ground plane. During the radiated emissions test, the turntable is rotated and any cables leaving the EUT are manipulated to find the configuration resulting in maximum emissions. The antenna height and polarization are varied during the testing to search for maximum signal levels. The height of the antenna is varied from one to four meters.

Detector function for radiated emissions are in QP mode from the frequency band 30MHz to 1GHz with RBW setting 120kHz and in PK & AV mode from frequency band 1GHz to 2GHz with RBW setting 1MHz. Detector function for conducted emissions are in QP & AV mode and IFBW setting is 9kHz from the frequency band 150kHz to 30MHz.

For radiated emission, the frequency range scanned is 30MHz to 2GHz. For line-conducted emissions, the range scanned is 150kHz to 30MHz.

8.1 Emissions Test Procedures (cont'd)

The EUT is warmed up for 15 minutes prior to the test.

Conducted measurements are made as described in ANSI C63.4 – 2009.

EXHIBIT 9 TEST EQUIPMENT LIST

9.0 Test Equipment List

Equipment No.	Equipment	Manufacturer	Model No.	Serial No.	Cal. Date	Due Date
SZ061-03	BiConiLog Antenna	ETS	3142C	00066460	02-Jul-11	02-Jan-13
SZ185-01	EMI Receiver	R&S	ESCI	100547	11-Mar-12	11-Mar-13
SZ188-01	Anechoic Chamber	ETS	RFD-F/A- 100	4102	03-Mar-12	03-Mar-13
SZ062-04	RF Cable	RADIALL	RG 213U		11-Mar-12	11-Mar-13
SZ062-06	RF Cable	RADIALL	0.04- 26.5GHz	083388	11-Mar-12	11-Mar-13
SZ185-02	EMI Test Receiver	R&S	ESCI	100692	05-Nov-11	05-Nov-12
SZ187-01	Two-Line V- Network	R&S	ENV216	100072	05-Nov-11	05-Nov-12
SZ187-02	Two-Line V- Network	R&S	ENV216	100073	05-Nov-11	05-Nov-12
SZ188-03	Shielding Room	ETS	RFD-100	4100	16-Sep-12	16-Sep-13